

Diamond Probes for

High Resolution AFM Imaging

maging

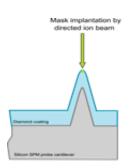
Trinity College Dublin

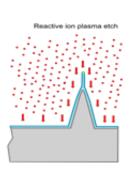
Available for investment

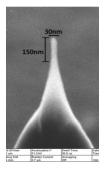
Basic overview

Atomic force microscopy (AFM) is a widely used metrology technique for imaging in the semi-conductor and hard drive industry. As technologies become increasingly smaller there is a drive to produce **more accurate metrology** and this is driven by the geometry of the AFM tip. Currently there is no cost effective solution that combines high resolution with a long tip lifetime.

The technology solution created by CRANN, Trinity College Dublin, converts a low resolution diamond tip into a **high resolution tip** using diamond patterning technology.







Probe fabrication process

Advantages

- Wafer-scale, batch processing enables cost-efficient fabrication methodology
- High resolution -< 25 nm tip diameter with 10:1 aspect ratio
- · Diamond has low wear and is very robust
- Chemically inert- resistant to wafer residue
- · High stiffness leading to higher speed imaging
- · Low adhesion properties

This production worthy fabrication process has been **developed and fully characterised** by CRANN.

Internal testing confirms the unique, successful combination of **high resolution and extended lifetime** diamond AFM tips.

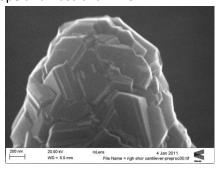
Applications

The application focus for this technology is high resolution metrology.

Technology and patent status

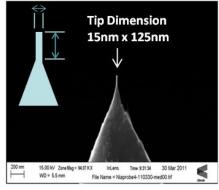
A prototype of this product is currently in test with a leading multi-national AFM supplier.

Patent applications have been nationalised in the US, Europe and Australia in 2011.



Low resolution diamond tip





Tip processed with diamond patterning technology-high resolution tip

The opportunity

The diamond patterning technology used to create the tip is patent-protected.

A start-up company is being formed to exploit the technology partnership / investment opportunities are available.

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